

# IRFZ46N

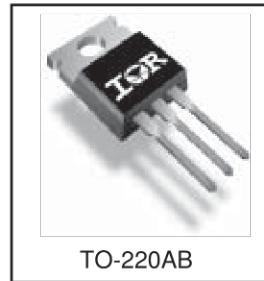
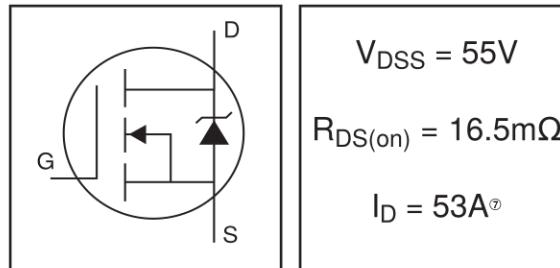
HEXFET® Power MOSFET

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated

## Description

Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



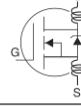
## Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	53 $\circ$	
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	37	A
$I_{DM}$	Pulsed Drain Current ①	180	
$P_D @ T_C = 25^\circ C$	Power Dissipation	107	W
	Linear Derating Factor	0.71	W/ $^\circ C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$I_{AR}$	Avalanche Current ①	28	A
$E_{AR}$	Repetitive Avalanche Energy ①	11	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	5.0	V/ns
$T_J$	Operating Junction and	-55 to + 175	
$T_{STG}$	Storage Temperature Range		$^\circ C$
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	
	Mounting torque, 6-32 or M3 screw	10 lbf-in (1.1N·m)	

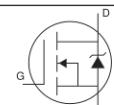
## Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{JC}$	Junction-to-Case	—	1.4	
$R_{CS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	$^\circ C/W$
$R_{JA}$	Junction-to-Ambient	—	62	

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

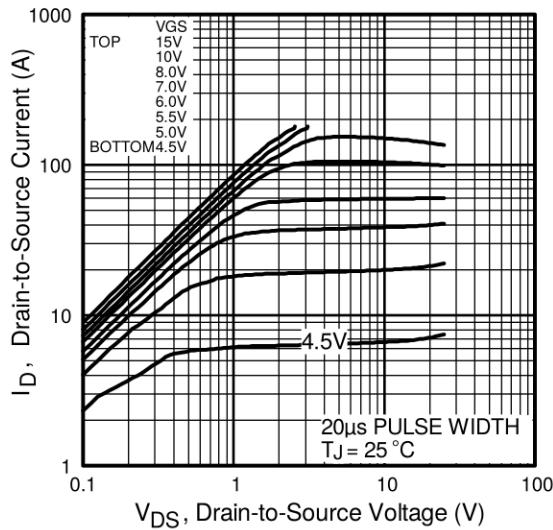
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	55	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.057	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	16.5	$\text{m}\Omega$	$V_{GS} = 10V, I_D = 28A$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
$g_f$	Forward Transconductance	19	—	—	S	$V_{DS} = 25V, I_D = 28A$ ④
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$	$V_{DS} = 55V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
$Q_g$	Total Gate Charge	—	—	72	$\text{nC}$	$I_D = 28A$
$Q_{gs}$	Gate-to-Source Charge	—	—	11		$V_{DS} = 44V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	26		$V_{GS} = 10V$ , See Fig. 6 and 13
$t_{d(on)}$	Turn-On Delay Time	—	14	—	$\text{ns}$	$V_{DD} = 28V$
$t_r$	Rise Time	—	76	—		$I_D = 28A$
$t_{d(off)}$	Turn-Off Delay Time	—	52	—		$R_G = 12\Omega$
$t_f$	Fall Time	—	57	—		$V_{GS} = 10V$ , See Fig. 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—	$\text{nH}$	Between lead, 6mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	1696	—	$\text{pF}$	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	407	—		$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	—	110	—		$f = 1.0\text{MHz}$ , See Fig. 5
$E_{AS}$	Single Pulse Avalanche Energy ②	—	583⑤	152⑥	$\text{mJ}$	$I_{AS} = 28A, L = 389\mu\text{H}$

**Source-Drain Ratings and Characteristics**

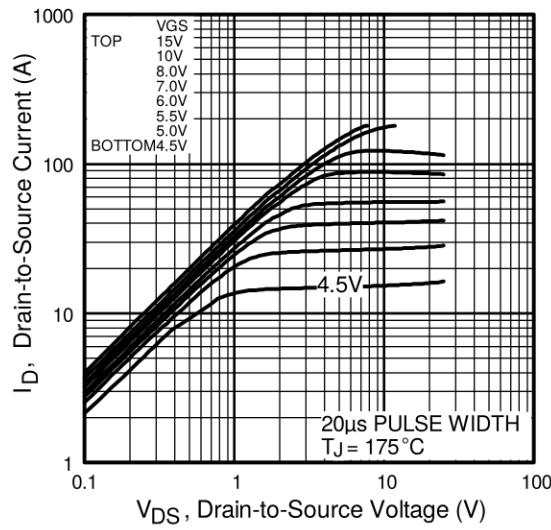
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	53	$\text{A}$	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode)①	—	—	180		
$V_{SD}$	Diode Forward Voltage	—	—	1.3		$T_J = 25^\circ\text{C}, I_S = 28A, V_{GS} = 0V$ ④
$t_{rr}$	Reverse Recovery Time	—	67	101	$\text{ns}$	$T_J = 25^\circ\text{C}, I_F = 28A$
$Q_{rr}$	Reverse Recovery Charge	—	208	312	$\text{nC}$	$dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

**Notes:**

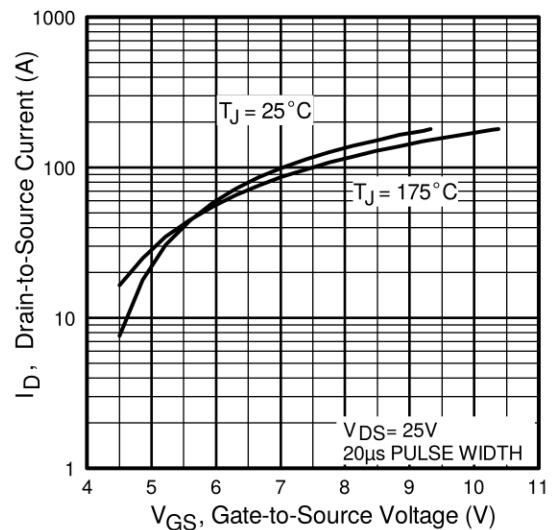
- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 ).
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 389\mu\text{H}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 28A$ . (See Figure 12).
- ③  $I_{SD} \leq 28A$ ,  $di/dt \leq 220\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  
 $T_J \leq 175^\circ\text{C}$ .
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤ This is a typical value at device destruction and represents operation outside rated limits.
- ⑥ This is a calculated value limited to  $T_J = 175^\circ\text{C}$ .
- ⑦ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 39A.



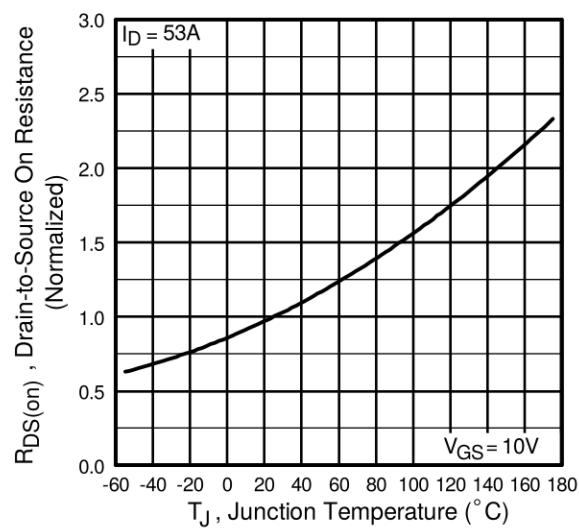
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



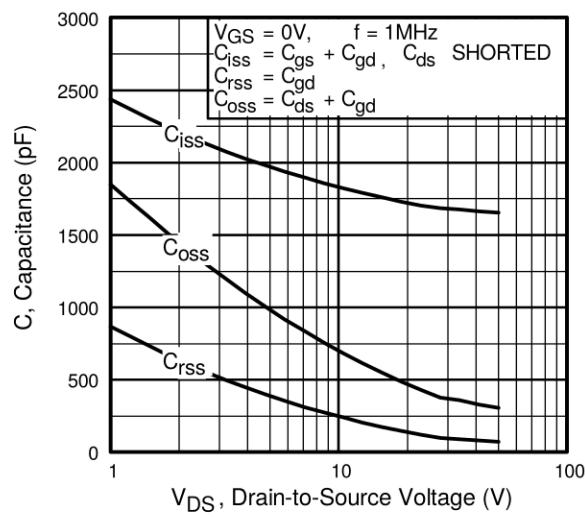
**Fig 3.** Typical Transfer Characteristics



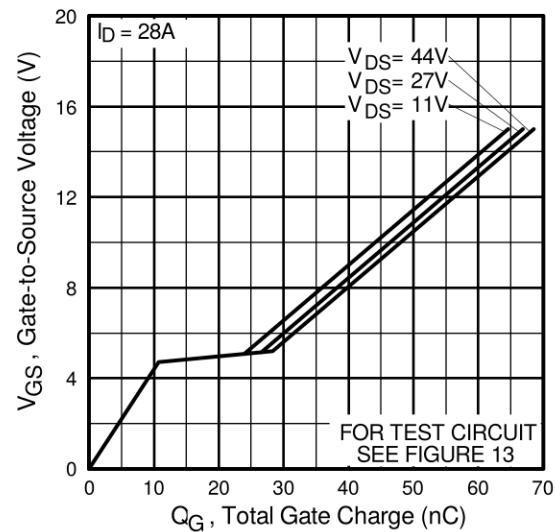
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

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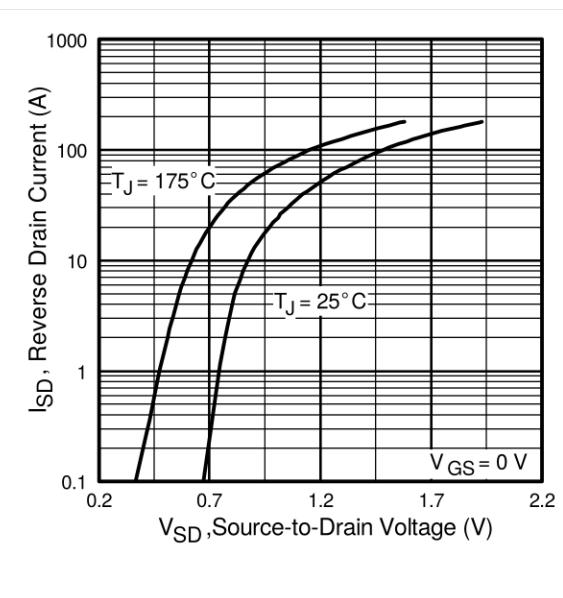
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Rectifier



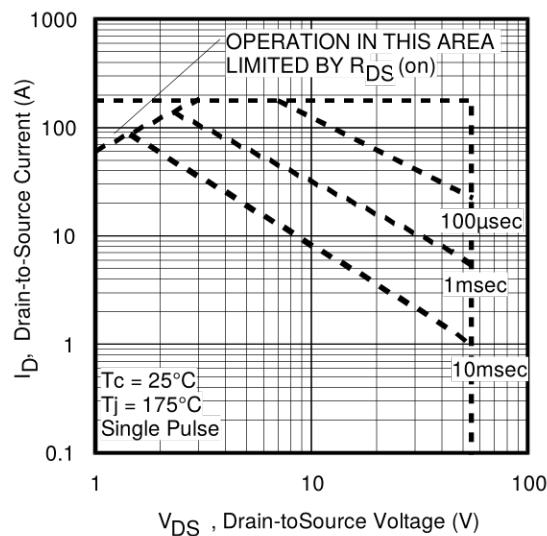
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



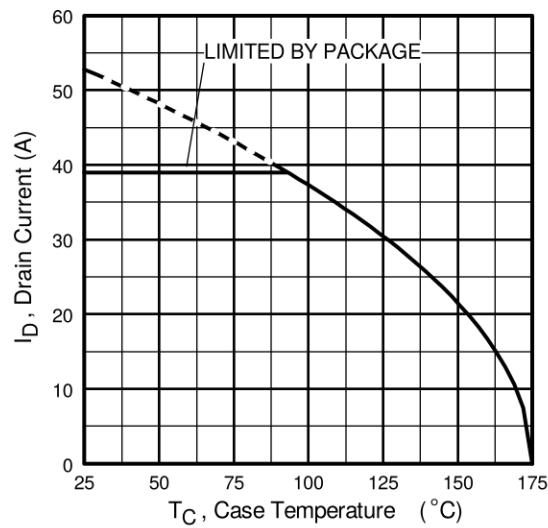
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



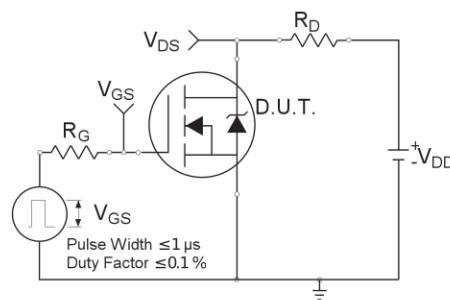
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



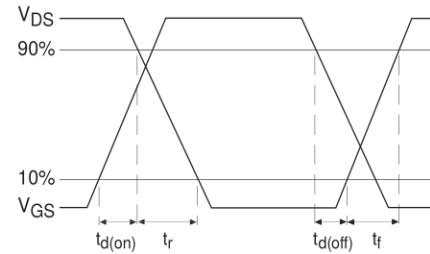
**Fig 8.** Maximum Safe Operating Area



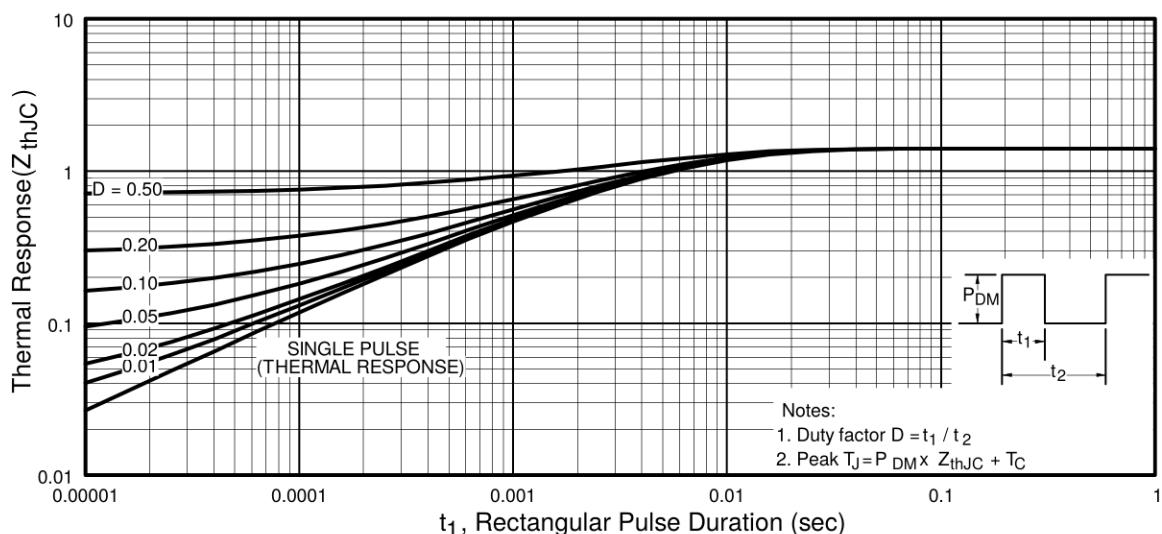
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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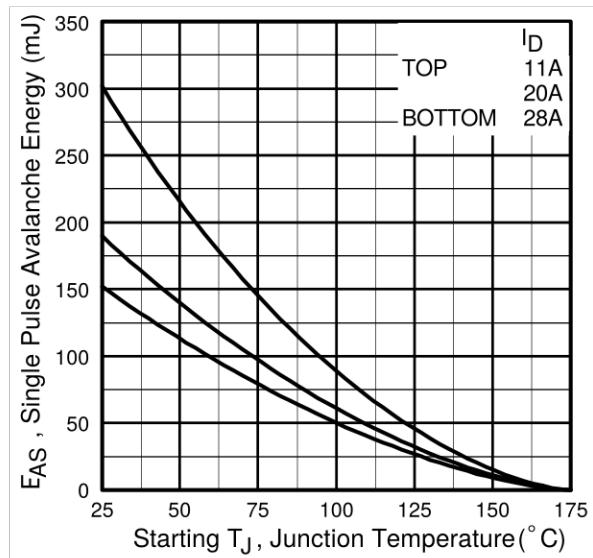
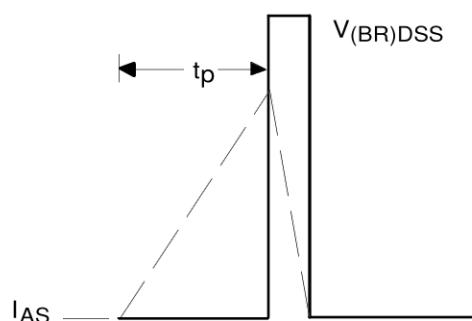
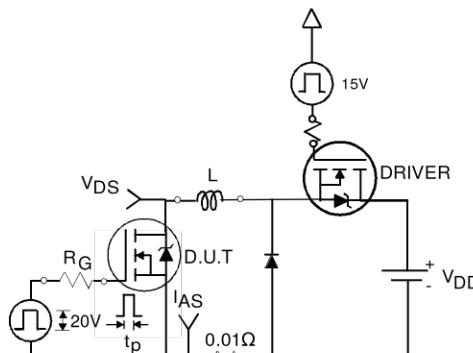
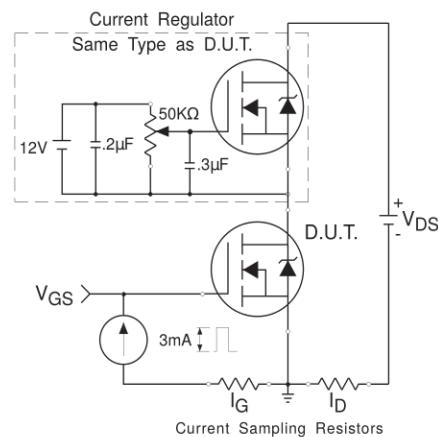
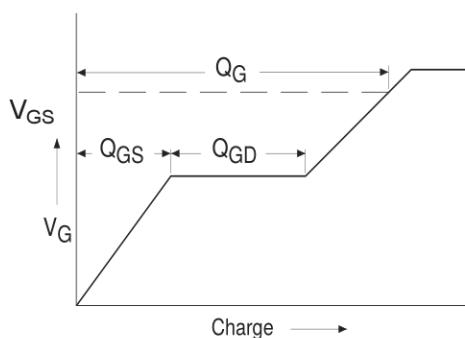
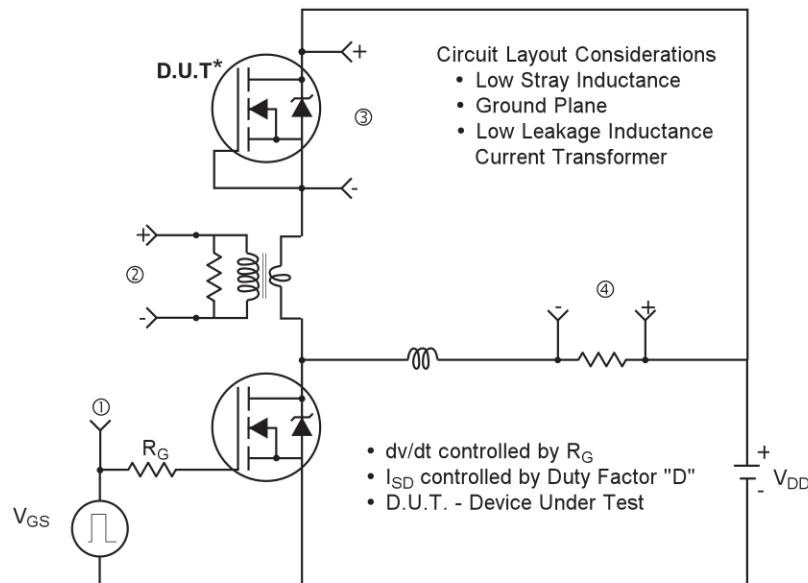


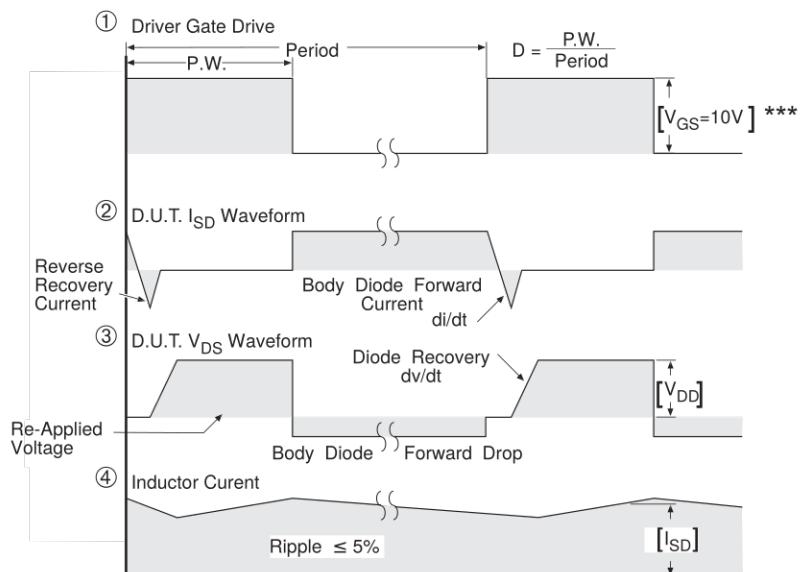
Fig 12c. Maximum Avalanche Energy Vs. Drain Current



### Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity of D.U.T for P-Channel



\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

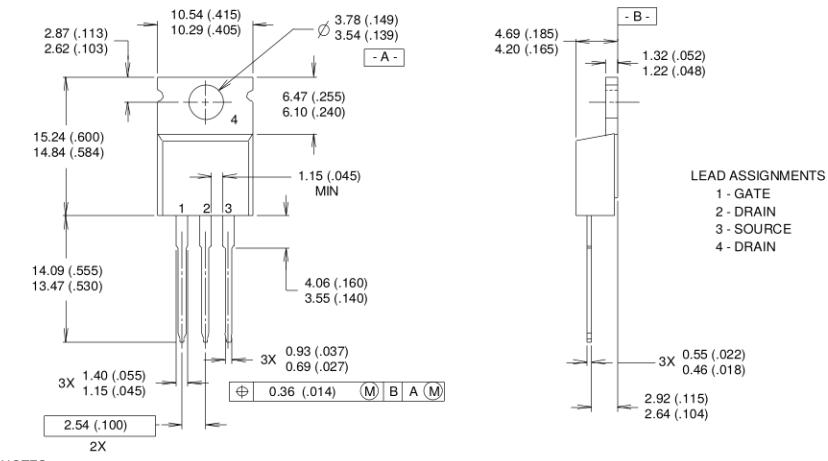
**Fig 14.** For N-channel HEXFET® power MOSFETs

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## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



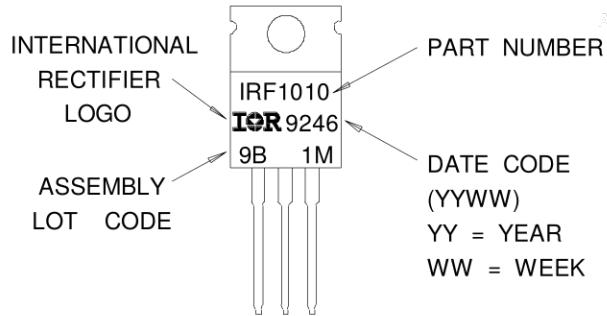
NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH

- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## TO-220AB Part Marking Information

EXAMPLE : THIS IS AN IRF1010  
WITH ASSEMBLY  
LOT CODE 9B1M



Data and specifications subject to change without notice.  
This product has been designed and qualified for the automotive [Q101] market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>